

Notice of References Cited

Application/Control No.

10/069,459

Applicant(s)/Patent Under

Reexamination

UCHIDA ET AL.

Examiner

Dah-Wei D. Yuan

Art Unit

1745

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,344,428	02-2002	Lim et al.	502/101
	B	US-6,641,862	11-2003	Grot, Stephen Andreas	427/115
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	L	US-			
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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